

FAIRCHILD
A Schlumberger Company

2N/PN/MPS/FTSO2369
2N/PN/MPS/FTSO2369A
2N/FTSO5769 7-35-15
NPN High Speed Saturated Switches

- $V_{CEO} \dots 15 \text{ V (Min)}$
- $t_s \dots 13 \text{ ns (Max) @ } 10 \text{ mA}$
- $t_{on} \dots 12 \text{ ns (Max) @ } 10 \text{ mA}$, $t_{off} \dots 18 \text{ ns (Max) @ } 10 \text{ mA}$
- **Complements ... 2N4209 (TO18), 2N5771 (TO92)**

ABSOLUTE MAXIMUM RATINGS (Note 1)

	MPS/PN2369/A	2N/FTSO5769
Temperatures		
Storage Temperature	-65° C to 200° C	-55° C to 150° C
Operating Junction Temperature	200° C	150° C

PACKAGE

2N2369	TO-18
2N2369A	TO-18
2N5769	TO-92
PN2369	TO-92
PN2369A	TO-92
MPS2369	TO-92
MPS2369A	TO-92
FTSO2369	TO-236AA/AB
FTSO2369A	TO-236AA/AB
FTSO5769	TO-236AA/AB

Power Dissipation (Notes 2 & 3)

	2N2369/A	2N5769 PN/MPS	FTSO
Total Dissipation at			
25° C Ambient Temperature	0.36 W	0.625 W	0.350 W*
100° C Case Temperature	0.68 W	0.260 W	
25° C Case Temperature	1.2 W	1.0 W	

Voltages & Currents

V_{CEO} Collector to Emitter Voltage	15 V
(Note 4)	
V_{CBO} Collector to Base Voltage	40 V
V_{CES} Collector to Emitter Voltage	40 V
V_{EBO} Emitter to Base Voltage	4.5 V
I_C Collector Current	200 mA
(Pulse = 10 μ s)	500 mA

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	2369		2369A 5769		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
BV_{CES}	Collector to Emitter Breakdown Voltage	40		40		V	$I_C = 10 \mu\text{A}$, $V_{BE} = 0$
BV_{CBO}	Collector to Base Breakdown Voltage	40		40		V	$I_C = 10 \mu\text{A}$, $V_{BE} = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	4.5		4.5		V	$I_E = 10 \mu\text{A}$, $I_C = 0$

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 200° C and junction-to-case thermal resistance of 146° C/W (derating factor of 6.85 mW/° C); junction-to-ambient thermal resistance of 486° C/W (derating factor of 2.06 mW/° C) for 2N2369, 2N2369A, PN2369 and PN2369A. These ratings give a maximum junction temperature of 150° C and junction-to-case thermal resistance of 125° C/W (derating factor of 8.0 mW/° C); junction-to-ambient thermal resistance of 200° C/W (derating factor of 5.0 mW/° C) for MPS2369 and 2N5769; (TO-236) junction-to-ambient thermal resistance of 357° C/W (derating factor of 2.8 mW/° C).
- Rating refers to a high current point where collector to emitter voltage is lowest.
- Pulse conditions: length = 300 μ s; duty cycle $\leq 2\%$.
- For product family characteristic curves, refer to Curve Set T132.
- Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm.

3469674 FAIRCHILD SEMICONDUCTOR

84D 27527 D ■

2N/PN/MPS/FTSO2369
 2N/PN/MPS/FTSO2369A
 2N/FTSO5769

T-35-15

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	2369		2369A 5769		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
I_{CBO}	Collector Cutoff Current		400 30		400 30	nA μ A	$V_{CB} = 20$ V, $I_E = 0$ $V_{CB} = 20$ V, $I_E = 0$, $T_A = 150^\circ$ C
h_{FE}	DC Pulse Current Gain (Note 5)	40 20	120	40 30 20	120		$I_C = 10$ mA, $V_{CE} = 1.0$ V $I_C = 100$ mA, $V_{CE} = 2.0$ V $I_C = 10$ mA, $V_{CE} = 0.35$ V $I_C = 30$ mA, $V_{CE} = 0.4$ V $I_C = 100$ mA, $V_{CE} = 1.0$ V $I_C = 10$ mA, $V_{CE} = 1.0$ V, $T_A = -55^\circ$ C $I_C = 10$ mA, $V_{CE} = 0.35$ V, $T_A = -55^\circ$ C
$V_{CE(sus)}$	Collector to Emitter Sustaining Voltage (Notes 4 & 5)	15		15		V	$I_C = 10$ mA (pulsed), $I_B = 0$
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Note 5)		0.25		0.2 0.25 0.5 0.3	V V V V V	$I_C = 10$ mA, $I_B = 1.0$ mA $I_C = 10$ mA, $I_B = 1.0$ mA $I_C = 30$ mA, $I_B = 3.0$ mA $I_C = 100$ mA, $I_B = 10$ mA $I_C = 10$ mA, $I_B = 10$ mA, $T_A = 125^\circ$ C
$V_{BE(sat)}$	Base to Emitter Saturation Voltage (Note 5)	0.70	0.85	0.70	0.85	V	$I_C = 10$ mA, $I_B = 1.0$ mA
C_{ob}	Output Capacitance		4.0		4.0	pF	$V_{CB} = 5.0$ V, $I_E = 0$, $f = 140$ kHz
h_{fe}	High Frequency Current Gain	5.0		5.0			$I_C = 10$ mA, $V_{CE} = 10$ V, $f = 100$ MHz
τ_s	Charge Storage Time Constant (test circuit no. 3111)		13		13	ns	$I_C = 10$ mA, $I_{B1} = I_{B2} = 10$ mA, $V_{CC} = 10$ V
t_{on}	Turn On Time (test circuit no. 210)		12		12	ns	$I_C = 10$ mA, $I_{B1} = 3.0$ mA, $V_{CC} = 3.0$ V
t_{off}	Turn Off Time (test circuit no. 210)		18		18	ns	$I_C = 10$ mA, $I_{B1} = 3.0$ mA, $I_{B2} = -1.5$ mA, $V_{CC} = 3.0$ V

SYMBOL	CHARACTERISTIC	MPS2369		UNITS	TEST CONDITIONS
		MIN	MAX		
BV_{CES}	Collector to Emitter Breakdown Voltage	40		V	$I_C = 10$ μ A, $V_{BE} = 0$
BV_{CBO}	Collector to Base Breakdown Voltage	40		V	$I_C = 10$ μ A, $V_{BE} = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	4.5		V	$I_E = 10$ μ A, $I_C = 0$
I_{CBO}	Collector Cutoff Current		400	nA	$V_{CB} = 20$ V, $I_E = 0$, $T_A = 150^\circ$ C
I_{CES}	Collector Cutoff Current		30	μ A	$V_{CB} = 20$ V, $I_E = 0$, $T_A = 125^\circ$ C

3469674 FAIRCHILD SEMICONDUCTOR

84D 27529 D

FAIRCHILD
A Schlumberger Company

2N2405

T-27-23

NPN Low Power Audio Frequency Transistor

ABSOLUTE MAXIMUM RATINGS (Note 1)**PACKAGE**

2N2405

TO-39

Temperatures

Storage Temperature -65°C to 200°C

Operating Junction Temperature 175°C

Power Dissipation (Notes 2 & 3)

Total Dissipation at

25°C Ambient Temperature 1.0 W

25°C Case Temperature 5.0 W

Voltages & CurrentsV_{CEO} Collector to Emitter Voltage 90 V
(Note 4)V_{CBO} Collector to Base Voltage 140 VV_{EBO} Emitter to Base Voltage 7.0 VI_C Collector Current 1.0 A**ELECTRICAL CHARACTERISTICS** (25°C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
BV _{CER}	Collector to Emitter Breakdown Voltage	140		V	I _C = 100 mA, R _{BE} = 10 Ω
BV _{CBO}	Collector to Base Breakdown Voltage	120		V	I _C = 100 μA, I _E = 0
BV _{EBO}	Emitter to Base Breakdown Voltage	7.0		V	I _E = 100 μA, I _C = 0
I _{EBO}	Emitter Cutoff Current		10	nA	V _{EB} = 5.0 V
I _{CBO}	Collector Cutoff Current		10 10	nA μA	V _{CB} = 90 V V _{CB} = 90 V, I _E = 0, T _A = 150°C
LV _{CEO}	Collector to Emitter Sustain Voltage	90 90		V V	I _C = 30 mA I _C = 100 mA
h _{FE}	DC Pulse Current Gain (Note 5)	60	200		I _C = 150 mA, V _{CE} = 10 V
h _{FE}	DC Current Gain (Note 5)	35			I _C = 10 mA, V _{CE} = 10 V

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 175°C and junction-to-case thermal resistance of 30°C/W (derating factor of 3.33 mW/°C); junction-to-ambient thermal resistance of 150°C/W (derating factor of 6.6 mW/°C).
- Rating refers to a high current point where collector to emitter voltage is lowest.
- Pulse conditions: length = 300 μs; duty cycle = 1.8%.
- For product family characteristic curves, refer to Curve Set T149.

2N2405

T-29-23

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage		0.5	V	$I_C = 150 \text{ mA}$, $I_B = 15 \text{ mA}$
$V_{BE(sat)}$	Base to Emitter Saturation Voltage		1.1	V	$I_C = 150 \text{ mA}$, $I_B = 15 \text{ mA}$
C_{ob}	Output Capacitance		15	pF	$V_{CB} = 10 \text{ V}$, $I_E = 0$, $f = 1.0 \text{ MHz}$
C_{ib}	Input Capacitance		80	pF	$V_{EB} = 0.5 \text{ V}$, $I_C = 0$
h_{fe}	Current Gain	50	275		$I_C = 5.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{ib}	Input Resistance	4	8	Ω	$I_C = 5.0 \text{ mA}$, $V_{CE} = 10 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{ob}	Output Conductance		0.5	μmhos	$I_C = 5.0 \text{ mA}$, $V_{CB} = 10 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{rb}	Voltage Feedback Ratio		3	$\times 10^{-4}$	$I_C = 5.0 \text{ mA}$, $V_{CB} = 10 \text{ V}$, $f = 1.0 \text{ kHz}$

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84D 27531 D

FAIRCHILD

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2N2484/FTSO2484**PN2484****2N3117/FTSO3117**

7-29-23

NPN Low Level Low Noise Amplifiers

- V_{CEO} ... 60 V (Min)
- h_{FE} ... 100-500 (2N/PN/FTSO2484), 250-500 (2N/FTSO3117) @ 10 μ A
- NF ... 3.0 dB (Max) (2N/PN/FTSO2484), 1.0 dB (Max) (2N/FTSO3117) @ 1.0 kHz, 2.0 dB (Max) (2N/PN/FTSO2484), 1.0 dB (Max) (2N/FTSO3117) @ 10 kHz

PACKAGE

2N2484	TO-18
2N3117	TO-18
PN2484	TO-92
FTSO2484	TO-236AA/AB
FTSO3117	TO-236AA/AB

ABSOLUTE MAXIMUM RATINGS (Note 1)

Temperatures	2N3117	PN/FTSO	2N2484
Storage Temperature	-65° C to 200° C	-55° C to 150° C	-65° C to 300° C
Operating Junction Temperature	200° C	150° C	200° C

Power Dissipation (Notes 2 & 3)

	2N	PN
Total Dissipation at		
25° C Ambient Temperature	0.36 mW	0.625 W
25° C Case Temperature	1.2 W	1.0 W
Total Dissipation at		
25° C Ambient Temperature	FTSO	
	0.350 W*	

Voltages & Currents

V_{CEO} Collector to Emitter Voltage	60 V
(Note 4)	
V_{CBO} Collector to Base Voltage	60 V
V_{EBO} Emitter to Base Voltage	6.0 V
I_C Collector Current	50 mA

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	2484		3117		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
BV_{CBO}	Collector to Base Breakdown Voltage	60		60		V	$I_C = 10 \mu A, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	6.0		6.0		V	$I_E = 10 \mu A, I_C = 0$
I_{CEO}	Collector to Emitter Cutoff Current		2.0			nA	$V_{CE} = 5.0 V, I_B = 0$
I_{EBO}	Emitter Cutoff Current		10		10	nA	$V_{EB} = 5.0 V, I_C = 0$
I_{CBO}	Collector Cutoff Current		10		10	nA	$V_{CB} = 45 V, I_E = 0$
			10		10	μA	$V_{CB} = 45 V, I_E = 0, T_A = 150^\circ C$

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 200° C and junction-to-case thermal resistance of 147° C/W (derating factor of 6.85 mW/° C); junction-to-ambient thermal resistance of 485° C/W (derating factor of 2.06 mW/° C) for 2N2484 and 2N3117. These ratings give a maximum junction temperature of 150° C and (TO-92) junction-to-case thermal resistance of 125° C/W (derating factor of 8.0 mW/° C); junction-to-ambient thermal resistance of 200° C/W (derating factor of 5.0 mW/° C); (TO-236) junction-to-ambient thermal resistance of 357° C/W (derating factor of 2.8 mW/° C).
- Rating refers to a high current point where collector to emitter voltage is lowest.
- Pulse conditions: length = 300 μ s; duty cycle = 1%.
- For product family characteristic curves, refer to Curve Set T107.
- * Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm.

3469674 FAIRCHILD SEMICONDUCTOR

84D 27532 D ■

2N2484/FTSO2484

PN2484

2N3117/FTSO3117

T-29-23

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	2484		3117		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
h_{FE}	DC Current Gain (Note 5)	250	800	400			$I_C = 10 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$ $I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$ $I_C = 500 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$ $I_C = 100 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$ $I_C = 10 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$ $I_C = 1.0 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$ $I_C = 10 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $T_A = -55^\circ\text{C}$
		200					
		175		300			
		100	500	250	500		
		30		100			
		20		50			
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage (Notes 4 & 5)	60		60		V	$I_C = 10 \text{ mA}$ (pulsed), $I_B = 0$

SYMBOL	CHARACTERISTIC	2484		3117		UNITS	TEST CONDITIONS
		MIN	MAX	MIN	MAX		
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Note 5)		0.35		0.35	V	$I_C = 1.0 \text{ mA}$, $I_B = 0.1 \text{ mA}$
$V_{BE(ON)}$	Base to Emitter "On" Voltage	0.5	0.7		0.7	V	$I_C = 100 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$
C_{ob}	Output Capacitance		6.0		4.5	pF	$V_{CB} = 5.0 \text{ V}$, $I_E = 0$, $f = 140 \text{ kHz}$
C_{ib}	Input Capacitance		6.0		6.0	pF	$V_{BE} = 0.5 \text{ V}$, $I_C = 0$, $f = 140 \text{ kHz}$
h_{fe}	High Frequency Current Gain	2.0		2.0			$I_C = 0.5 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 30 \text{ MHz}$ $I_C = 50 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $f = 5.0 \text{ MHz}$ $I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
		3.0					
		150	900	400	900		
h_{ie}	Input Resistance	3.5	24	10	24	k Ω	$I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{oe}	Output Conductance		40		40	μmhos	$I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{re}	Reverse Voltage Feedback Ratio		800		800	$\times 10^{-6}$	$I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f \div 1.0 \text{ kHz}$
NF	Wide Band Noise Figure		3.0			dB	$I_C = 10 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $R_S = 10 \text{ k}\Omega$, Power Bandwidth of 15.7 kHz with 3.0 dB pts at 10 Hz and 10 kHz

2N2484/FTSO2484

PN2484

2N3117/FTSO3117

T-29-23

Electrical Characteristics (25° C Ambient Temperature unless otherwise noted)

Symbol	Characteristic	Min.	Max.	Units	Test Conditions
NF	Narrow Band Noise Figure	3.0		dB	$I_C = 10 \mu A$, $V_{CE} = 5.0 V$, $f = 1.0 \text{ kHz}$, $R_S = 10 \text{ k}\Omega$ Power Bandwidth of 200 Hz
		2.0		dB	$I_C = 10 \mu A$, $V_{CE} = 5.0 V$, $f = 10 \text{ kHz}$, $R_S = 10 \text{ k}\Omega$, Power Bandwidth of 2.0 kHz
		10		dB	$I_C = 10 \mu A$, $V_{CE} = 5.0 V$, $f = 100 \text{ Hz}$, $R_S = 10 \text{ k}\Omega$, Power Bandwidth of 20 Hz
			1.0	dB	$I_C = 5.0 \mu A$, $V_{CE} = 5.0 V$, $f = 1.0 \text{ kHz}$, $R_S = 50 \text{ k}\Omega$, Power Bandwidth of 200 Hz
			1.0	dB	$I_C = 5.0 \mu A$, $V_{CE} = 5.0 V$, $f = 10 \text{ kHz}$, $R_S = 50 \text{ k}\Omega$, Power Bandwidth of 1.0 kHz
			4.0	dB	$I_C = 30 \mu A$, $V_{CE} = 5.0 V$, $f = 100 \text{ kHz}$, $R_S = 10 \text{ k}\Omega$, Power Bandwidth of 20 Hz
			1.5	dB	$I_C = 30 \mu A$, $V_{CE} = 5.0 V$, $f = 10 \text{ Hz}$, $R_S = 10 \text{ k}\Omega$, Power Bandwidth of 2.0 Hz

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84D 27534 D'

FAIRCHILD

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2N2586

7-29-23

NPN Low Level Low Noise Type

ABSOLUTE MAXIMUM RATINGS (Note 1)**PACKAGE**
2N2586

TO-18

Temperatures

Storage Temperature -65° C to 200° C
 Operating Junction Temperature 175° C

Power Dissipation (Notes 2 & 3)

Total Dissipation at 25° C Ambient Temperature 0.4 W
 25° C Case Temperature 1.8 W

Voltages & Currents

V_{CEO} Collector to Emitter Voltage 45 V
 (Note 4)
 V_{CBO} Collector to Base Voltage 60 V
 V_{EBO} Emitter to Base Voltage 6.0 V
 I_C Collector Current 30 mA

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
BV_{CBO}	Collector to Base Breakdown Voltage	60		V	$I_C = 10 \mu A, I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	6.0		V	$I_E = 10 \mu A, I_C = 0$
I_{CEO}	Collector to Emitter Cutoff Current		2.0	nA	$V_{CE} = 5.0 V, I_B = 0$
I_{CES}	Collector to Emitter Cutoff Current		2.0 10	nA μA	$V_{CE} = 45 V, V_{BE} = 0$ $V_{CE} = 45 V, V_{BE} = 0, T_A = 170^\circ C$
I_{CBO}	Collector Cutoff Current		2.0	nA	$V_{CB} = 45 V, I_E = 0$
I_{EBO}	Emitter Cutoff Current		2.0	nA	$V_{EB} = 5.0 V, I_C = 0$
h_{FE}	DC Pulse Current Gain (Note 5)		600		$I_C = 10 mA, V_{CE} = 5.0 V$
h_{FE}	DC Current Gain	150 120 80 40	360		$I_C = 500 \mu A, V_{CE} = 5.0 V$ $I_C = 10 \mu A, V_{CE} = 5.0 V$ $I_C = 1.0 \mu A, V_{CE} = 5.0 V$ $I_C = 10 \mu A, V_{CE} = 5.0 V, T_A = 55^\circ C$

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 175° C and junction-to-case thermal resistance of 250° C/W (derating factor of 4.0 mW/° C); junction-to-ambient thermal resistance of 500° C/W (derating factor of 2.0 mW/° C).
- Rating refers to a high current point where collector to emitter voltage is lowest.
- Pulse conditions: length = 300 μs ; duty cycle $\leq 2\%$.
- For product family characteristic curves, refer to Curve Set T107.

3469674 FAIRCHILD SEMICONDUCTOR

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2N2586

T-29-23

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
$V_{CE(sus)}$	Collector to Emitter Sustaining Voltage (Notes 4 & 5)	45		V	$I_C = 10 \text{ mA}$, $I_B = 0$
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage		0.5	V	$I_C = 10 \text{ mA}$, $I_B = 0.5 \text{ mA}$
V_{BE}	Base to Emitter Voltage	0.7	0.9	V	$I_C = 10 \text{ mA}$, $I_B = 0.5 \text{ mA}$
C_{obo}	Common Base Open Circuit Output Capacitance		7.0	pF	$V_{CB} = 5.0 \text{ V}$, $I_E = 0$, $f = 1.0 \text{ MHz}$
h_{fe}	High Frequency Current Gain	1.5			$I_C = 500 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $f = 30 \text{ MHz}$
h_{fe}	Small Signal Current Gain	150	600		$I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{ie}	Input Resistance	4.5	18	k Ω	$I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
h_{oe}	Output Admittance		100	μmhos	$I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ V}$, $f = 1.0 \text{ kHz}$
NF	Spot Noise Figure		2.0	dB	$I_C = 1.0 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $R_G = 1.0 \text{ M}\Omega$, $f = 10 \text{ kHz}$
			2.0	dB	$I_C = 10 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $R_G = 10 \text{ k}\Omega$, $f = 10 \text{ kHz}$
			3.0	dB	$I_C = 10 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $R_G = 10 \text{ k}\Omega$, $f = 1.0 \text{ kHz}$
			3.5	dB	$I_C = 1.0 \mu\text{A}$, $V_{CE} = 5.0 \text{ V}$, $R_G = 1 \text{ M}\Omega$, $f = 1.0 \text{ kHz}$